

<b>Notice of References Cited</b>	Application/Control No. 10/783,558		Applicant(s)/Patent Under Reexamination DAY ET AL.	
	Examiner Roderick Tolentino		Art Unit 2439	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0143961	10-2002	Siegel et al.	709/229
*	B	US-6,370,141	04-2002	Giordano et al.	370/386
*	C	US-6,470,454	10-2002	Challener et al.	726/17
*	D	US-2004/0210928	10-2004	Hamzy et al.	725/031
*	E	US-7,210,158	04-2007	Forler, Joseph Wayne	725/31
*	F	US-2002/0095591	07-2002	Daniell et al.	713/200
*	G	US-2003/0129975	07-2003	Sim, Ji-Saob	455/418
*	H	US-2004/0003279	01-2004	Beilinson et al.	713/200
*	I	US-2004/0199763	10-2004	Freund, Gregor P.	713/154
*	J	US-2004/0193606	09-2004	Arai et al.	707/009
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.